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	10828707	TAN ET AL.
	Examiner	Art Unit
	Whipkey, Jason T	2622

Jason Whipkey (Assistant Examiner)	11/20/2007 (Date)	 LIN YE	Total Claims Allowed: 16
Wendy Blawson (Legal Instruments Examiner)	11/29/07 (Date)	SUPERVISORY PATENT EXAMINER (Primary Examiner)	O.G. Print Claim(s) 1